

## Dual N-Channel 30 V (D-S) MOSFET

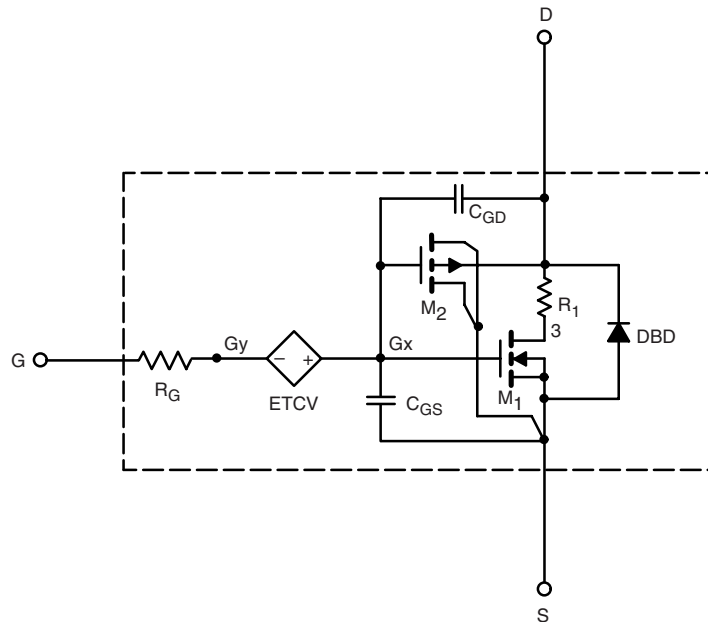
### DESCRIPTION

The attached SPICE model describes the typical electrical characteristics of the n-channel vertical DMOS. The subcircuit model is extracted and optimized over the - 55 °C to + 125 °C temperature ranges under the pulsed 0 V to 10 V gate drive. The saturated output impedance is best fit at the gate bias near the threshold voltage. A novel gate-to-drain feedback capacitance network is used to model the gate charge characteristics while avoiding convergence difficulties of the switched  $C_{gd}$  model. All model parameter values are optimized to provide a best fit to the measured electrical data and are not intended as an exact physical interpretation of the device.

### CHARACTERISTICS

- N-Channel Vertical DMOS
- Macro Model (Subcircuit Model)
- Level 3 MOS
- Apply for both Linear and Switching Application
- Accurate over the - 55 °C to + 125 °C Temperature Range
- Model the Gate Charge, Transient, and Diode Reverse Recovery Characteristics

### SUBCIRCUIT MODEL SCHEMATIC



### Note

This document is intended as a SPICE modeling guideline and does not constitute a commercial product datasheet. Designers should refer to the appropriate datasheet of the same number for guaranteed specification limits.

# SPICE Device Model Si5906DU

Vishay Siliconix

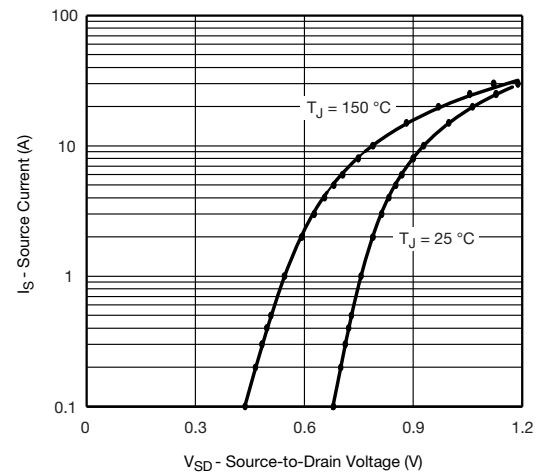
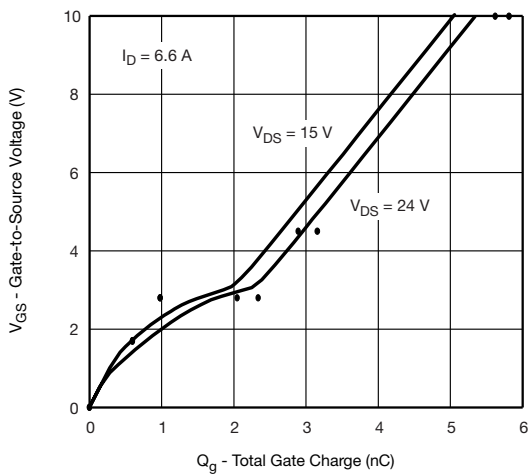
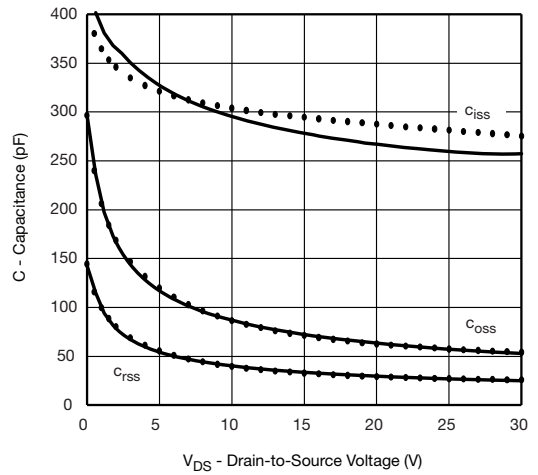
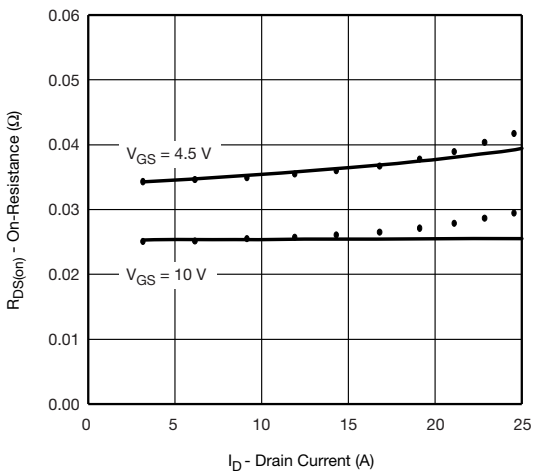
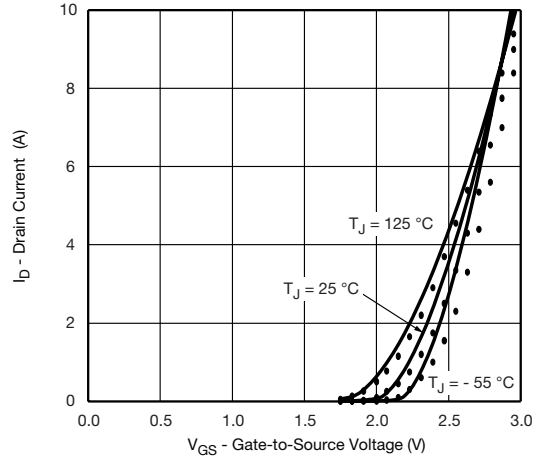
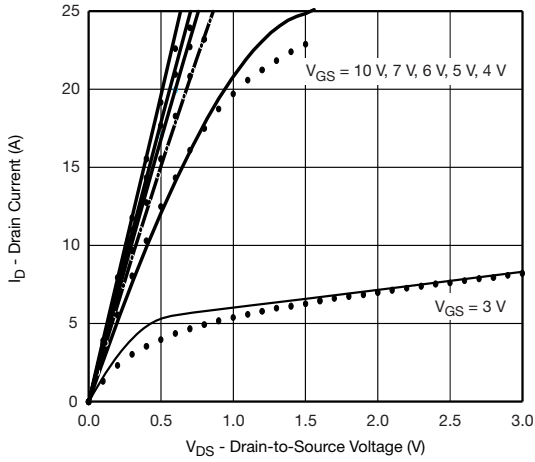


| SPECIFICATIONS $T_J = 25\text{ }^\circ\text{C}$ , unless otherwise noted |              |   |                |               |          |
|--|--------------|---|----------------|---------------|----------|
| PARAMETER  | SYMBOL       | TEST CONDITIONS   | SIMULATED DATA | MEASURED DATA | UNIT     |
| <b>Static</b>  |              |   |                |               |          |
| Gate-Source Threshold Voltage  | $V_{GS(th)}$ | $V_{DS} = V_{GS}$ , $I_D = 250\text{ }\mu\text{A}$                      | 1.4            | -             | V        |
| Drain-Source On-State Resistance <sup>a</sup>                            | $R_{DS(on)}$ | $V_{GS} = 10\text{ V}$ , $I_D = 4.8\text{ A}$                           | 0.025          | 0.025         | $\Omega$ |
|  |              | $V_{GS} = 4.5\text{ V}$ , $I_D = 4.1\text{ A}$                          | 0.034          | 0.033         |          |
| Forward Transconductance <sup>a</sup>                                    | $g_{fs}$     | $V_{DS} = 15\text{ V}$ , $I_D = 4.8\text{ A}$                           | 14             | 14            | S        |
| Body Diode Voltage   | $V_{SD}$     | $I_S = 6\text{ A}$  | 0.86           | 0.80          | V        |
| <b>Dynamic<sup>b</sup></b>   |              |   |                |               |          |
| Input Capacitance  | $C_{iss}$    | $V_{DS} = 15\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 1\text{ MHz}$     | 278            | 300           | pF       |
| Output Capacitance   | $C_{oss}$    |   | 72             | 72            |          |
| Reverse Transfer Capacitance   | $C_{rss}$    |   | 34             | 34            |          |
| Total Gate Charge  | $Q_g$        | $V_{DS} = 15\text{ V}$ , $V_{GS} = 10\text{ V}$ , $I_D = 6.6\text{ A}$  | 5.5            | 5.7           | nC       |
|  |              | $V_{DS} = 15\text{ V}$ , $V_{GS} = 4.5\text{ V}$ , $I_D = 6.6\text{ A}$ | 2.7            | 2.9           |          |
| Gate-Source Charge   | $Q_{gs}$     | $V_{DS} = 15\text{ V}$ , $V_{GS} = 4.5\text{ V}$ , $I_D = 6.6\text{ A}$ | 1              | 1             |          |
| Gate-Drain Charge  | $Q_{gd}$     | $V_{DS} = 15\text{ V}$ , $V_{GS} = 4.5\text{ V}$ , $I_D = 6.6\text{ A}$ | 1.1            | 1.1           |          |

## Notes

- a. Pulse test; pulse width  $\leq 300\text{ }\mu\text{s}$ , duty cycle  $\leq 2\%$ .
- b. Guaranteed by design, not subject to production testing.

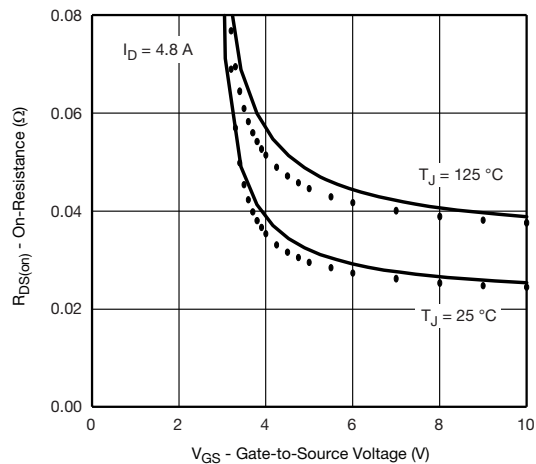
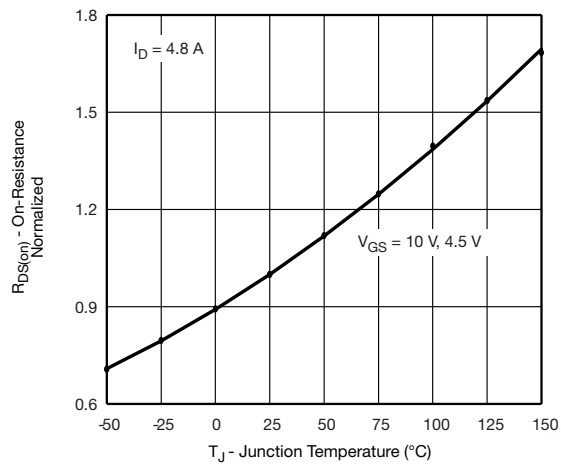
## COMPARISON OF MODEL WITH MEASURED DATA $T_J = 25\text{ }^\circ\text{C}$ , unless otherwise noted



### Note

Dots and squares represent measured data.

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Dots and squares represent measured data.



## Disclaimer

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